## Applicant(s)/Patent Under Application/Control No. Reexamination 10/823,613 WILES ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2817 Hieu Nguyen **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY 330/59 US-5,786,730 07-1998 Hadley, Maxwell Richard Α 330/69 Yoon, Taesub Ty US-6,593,810 07-2003 В С US-US- . D US-Ε US-F G US-US-Н 1 US-US-Κ US-US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Classification Name Country Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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